

<b>Notice of References Cited</b>	Application/Control No. 09/752,898		Applicant(s)/Patent Under Reexamination HUFFMAN ET AL.	
	Examiner Hai V. Nguyen		Art Unit 2142	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,671,514	12-2003	Cedervall et al.	455/456.1
	C	US-6,243,746	06-2001	Sondur et al.	709/220
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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